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(Modified) PATENT AND TRADEMARK OFFICE			217704US2PCT	10/019,018					
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LIST OF REFERENCES CITED BY APPLICANTS.\ Atsushi IKEDA, et al.									
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EXAMINER DOCUMENT				December 26, 2001		2632			
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	AP	8-22068	01/23/1996	JAPAN (with English Abstract)				x	
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)									
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Examiner Daintio W. Koins					Date Co	Date Considered 11/8/04			
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